# PREPARATION METHOD



# **Aluminium based alloys**

## Recommended machines and additional consumables (not included)

# CUTTING

Notes:

**Equipment ATM Brillant** 



**Equipment** ATM Opal

<u></u>	GRINDING/ POLISHING

Sample size Ø 40 mm

#### **Consumables**

Cut-off wheel: corundum, resin bond Anti-corrosion coolant

#### **Consumables**

Hot mounting: Bakelite red/black Cold mounting: KEM 20, KEM 30 Hot mounting prefered

#### Pressure parameters and specimen size

Specimen diameter [mm]	25	30	40	50	60
Divergence in pressure used in the preparation methods	-(5 N10 N)	-5 N	0	+5 N	+(5 N10 N)

STEP	MEDIUM	4 <u>-</u> ->-	rpm	€	Single Pressure N	min
Planar grinding	SiC-paper/foil P320 (280)	H <sub>2</sub> O	250-300	►► Synchronous Rotation	25	Until plane
Pre-polishing	ВЕТА	Dia-Complete Poly, 9 µm	120-150	<b>⋖►</b> Counter Rotation	25	3:00-5:00
Polishing	SIGMA	Dia-Complete Poly, 3 μm	120-150	►► Synchronous Rotation	30	3:00-5:00
Final polishing	OMEGA	Eposil F 0.1 μm	120-150	<b>⋖►</b> Counter Rotation	20	1:00-2:00 (H <sub>2</sub> O during final 0:30)
Optional: Etching (chem.)	Kroll´s Reagent*					Approx. 0:30

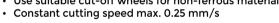
<sup>\*</sup> ATM Item No. 92004492

## **BEGINNERS GUIDE**



CUTTING

• Use suitable cut-off wheels for non-ferrous material (e.g. ATM NF-A wheels)





MOUNTING

· Use mounting material with high edge retention



- Grind with SiC-paper/foil P320 (280)
- Thoroughly wash samples and holder under running water after each grinding step
- Use 1 sheet of SiC-paper/foil for maximum 4 samples
- For new materials start with longest recommended step times and optimize to shorter times
- Rinse the polishing discs with water and spin dry after use · Do not stack discs with different diamond sizes
- Clean samples, holders and hands under running water before each polishing step
- Use ethanol and blow dryer to avoid water stains
- Check after each step under the microscope if polishing marks are of equal size and randomly oriented • Rinse the OMEGA disc with water and spin dry after use
- Use the consumables only for aluminium based alloys and not for other materials • Rinse the cap of the Eposil F bottle after use, put cap back on

# **SAMPLE MICROGRAPHS**

## **OK Sample polished**

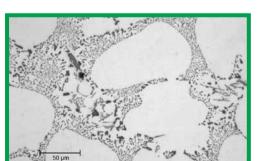
20x microscopy of Al-Si casting after OMEGA polishing

- Primary aluminium phase free of scratches
- · Eutectic and intermetallic phases clearly visible

## **NOK Sample polished**

20x microscopy of Al-Si casting after OMEGA polishing

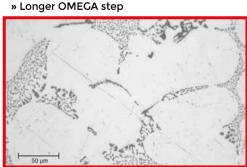
- Long scratches despite OMEGA step » OMEGA disc contaminated with large
- particles » Wash disc under running water,
- spin dry at 500 RPM
- » Clean sample and sample holder
- · Interrupted shallow scratches, pores in line formation » Longer OMEGA step

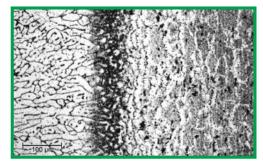


**OK Etched Sample** 

10x micrograph of Al fusion weld, etched with Kroll´s reagent for 15 sec

- · Heat-affected zone and base material
- (left to right) clearly discernable · No residual scratches, no relief





Notes:
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**Notes:**